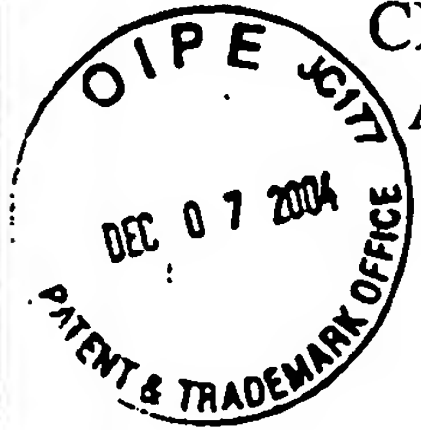

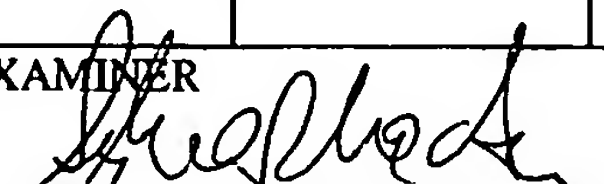


<b>INFORMATION DISCLOSURE CITATION IN AN APPLICATION</b>  (PTO-1449)			ATTY. DOCKET NO. 007734 USA/ FPS/MMCS/APC		SERIAL NO. 10/665,165	
			APPLICANT Joseph Young J. PAIK			
			FILING DATE September 18, 2003		GROUP	
<b>U.S. PATENT DOCUMENTS</b>						
EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE
<i>[Signature]</i>	6,381,564 B1	04/30/02	David et al.			05/03/99
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<i>[Signature]</i>	6,735,492 B2	05/11/04	Conrad et al.			07/19/02
EXAMINER <i>[Signature]</i>			DATE CONSIDERED <i>9/22/05</i>			


EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

<p align="center"><b>INFORMATION DISCLOSURE CITATION IN AN APPLICATION</b></p> <p align="center">(PTO-1449)</p> 	<p>ATTY. DOCKET NO. 007734 USA/ FPS/MMCS/APC</p>	<p>SERIAL NO. 10/665,165</p>
	<p>APPLICANT Joseph Young J. PAIK</p>	
	<p>FILING DATE September 18, 2003</p>	<p>GROUP _____</p>
<p align="center"><b>OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)</b></p>		
<p><i>SM</i></p>	<p>September 15, 2004. Office Action for U.S. Serial No. 10/632,107, filed August 1, 2003.</p>	
<p><i>SM</i></p>	<p>September 29, 2004. Office Action for U.S. Serial No. 09/363,966, filed July 29, 1999.</p>	
<p><i>SM</i></p>	<p>October 1, 2004. International Preliminary Examination Report for PCT Serial No. PCT/US03/23964.</p>	
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<p><i>SM</i></p>	<p>October 12, 2004. International Preliminary Examination Report for PCT Serial No. PCT/US02/19061.</p>	
<p><i>SM</i></p>	<p>November 17, 2004. Written Opinion for PCT Serial No. PCT/US01/27407.</p>	
<p>EXAMINER <i>Shirley MacArthur</i></p>	<p>DATE CONSIDERED 9/7/05</p>	

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				FILING DATE September 18, 2003		GROUP	
U.S. PATENT DOCUMENTS							
EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE	
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[Signature]	6,652,355 B2	11/25/03	Wiswesser et al.			06/04/01	
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EXAMINER 			DATE CONSIDERED 9/22/05				

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		APPLICANT Joseph Young J. PAIK	
		FILING DATE September 18, 2003	GROUP
<b>OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)</b>			
sh	IslamRaja, M. M., C. Chang, J. P. McVittie, M. A. Cappelli, and K. C. Saraswat. May/June 1993. "Two Precursor Model for Low-Pressure Chemical Vapor Deposition of Silicon Dioxide from Tetraethylorthosilicate." <i>J. Vac. Sci. Technol. B</i> , Vol. 11, No. 3, pp. 720-726.		
sh	Kim, Eui Jung and William N. Gill. July 1994. "Analytical Model for Chemical Vapor Deposition of SiO <sub>2</sub> Films Using Tetraethoxysilane and Ozone" (Abstract). <i>Journal of Crystal Growth</i> , Vol. 140, Issues 3-4, pp. 315-326.		
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sh	September 16, 2004. International Preliminary Examination Report for PCT Serial No. PCT/US02/24859.		
EXAMINER	DATE CONSIDERED		
sh	9/22/05		

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